

SIOV metal oxide varistors

Leaded varistors, SuperioR, S25 series

Series/Type: B722*
Date: January 2018

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EPCOS AG is a TDK Group Company.

SuperioR, S25 series
Construction

- Round varistor element, leaded
- Coating: epoxy resin, flame-retardant to UL 94 V-0
- Terminals: tinned wire

Features

- High-energy SuperioR series E4
- Wide operating voltage range 130 ... 750 V_{RMS}
- All types duty cycle @ 6 kV/ 3 kA = >10 pulses, according to IEC 62368-1; G.8.2 and IEC 60950-1; Annex Q, IEC 61051-2
- UL approval to UL 1449 (file number E321126 – exception 580 V)
- Very high surge current rating up to 20 kA

Approvals

- UL
- CSA
- IEC
- VDE

Delivery mode

- Bulk (standard)
- For further details refer to chapter "Taping, packaging and lead configuration" for leaded varistors.

General technical data

Climatic category	to IEC 60068-1	40/105/56	
Operating temperature	to IEC 61051	-40 ... +105	°C
Storage temperature		-40 ... +125	°C
Electric strength	to IEC 61051	≥ 2.5	kV _{RMS}
Insulation resistance	to IEC 61051	≥ 100	MΩ


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Electrical specifications and ordering codes
Maximum ratings ($T_A = 105\text{ °C}$)

Ordering code	Type (untaped) SIOV-	V_{RMS}	V_{DC}	i_{max} (8/20 μ s) 1 time	I_n ¹⁾ (8/20 μ s) 15 times	W_{max} (2 ms)	P_{max}
		V	V	A	A	J	W
B72225S4131K101	S25K130E4R12	130	170	20000	10000	185	1.0
B72225S4141K101	S25K140E4R12	140	180	20000	10000	195	1.0
B72225S4151K101	S25K150E4R12	150	200	20000	10000	215	1.0
B72225S4171K101	S25K175E4R12	175	225	20000	10000	245	1.0
B72225S4231K101	S25K230E4R12	230	300	20000	10000	315	1.0
B72225S4251K101	S25K250E4R12	250	320	20000	10000	345	1.0
B72225S4271K101	S25K275E4R12	275	350	20000	10000	375	1.0
B72225S4301K101	S25K300E4R12	300	385	20000	10000	410	1.0
B72225S4321K101	S25K320E4R12	320	420	20000	10000	445	1.0
B72225S4381K101	S25K385E4R12	385	505	20000	10000	600	1.0
B72225S4421K101	S25K420E4R12	420	560	20000	10000	700	1.0
B72225S4441K101	S25K440E4R12	440	585	20000	10000	710	1.0
B72225S4461K101	S25K460E4R12	460	615	20000	10000	720	1.0
B72225S4511K101	S25K510E4R12	510	670	20000	10000	750	1.0
B72225S4551K101	S25K550E4R12	550	745	20000	10000	780	1.0
B72225S4581K101	S25K580E4R12	580	780	20000	10000	800	1.0
B72225S4621K101	S25K625E4R12	625	825	20000	10000	855	1.0
B72225S4681K101	S25K680E4R12	680	895	20000	10000	940	1.0
B72225S4751K101	S25K750E4R12	750	1060	20000	10000	1025	1.0

¹⁾ **Note:** Nominal discharge current I_n according to UL 1449, 4th edition.


Characteristics (T_A = 25 °C)

Ordering code	V _V (1 mA) V	ΔV _V (1 mA) %	V _{C,max} (i _C) V	i _C A	C _{typ} (1 kHz) pF
	B72225S4131K101	205	±10	340	150
B72225S4141K101	220	±10	360	150	3550
B72225S4151K101	240	±10	395	150	3250
B72225S4171K101	270	±10	455	150	2900
B72225S4231K101	360	±10	595	150	2250
B72225S4251K101	390	±10	650	150	2100
B72225S4271K101	430	±10	710	150	1900
B72225S4301K101	470	±10	775	150	1750
B72225S4321K101	510	±10	840	150	1600
B72225S4381K101	620	±10	1025	150	1250
B72225S4421K101	680	±10	1120	150	1150
B72225S4441K101	715	±10	1180	150	1100
B72225S4461K101	750	±10	1240	150	1050
B72225S4511K101	820	±10	1355	150	950
B72225S4551K101	910	±10	1500	150	860
B72225S4581K101	940	±10	1580	150	830
B72225S4621K101	1000	±10	1650	150	780
B72225S4681K101	1100	±10	1815	150	710
B72225S4751K101	1200	±10	2000	150	650


Dimensional drawings


1) Seating plane to IEC 60717

VAR0408-C-E

Weight

Nominal diameter mm	V_{RMS} V	Weight g
25	130 ... 750	5.2 ... 22.2

The weight of varistors in between these voltage classes can be interpolated.

Dimensions

Ordering code	[e] ±1 mm	a (typical) mm	w_{max} mm	th_{max} mm	h_{max} mm	l_{min} mm	d ±0.05 mm
B72225S4131K101	12.7	3.4	27.5	5.7	31.0	25.0	1.0
B72225S4141K101	12.7	3.5	27.5	5.8	31.0	25.0	1.0
B72225S4151K101	12.7	3.6	27.5	5.9	31.0	25.0	1.0
B72225S4171K101	12.7	3.8	27.5	6.1	31.0	25.0	1.0
B72225S4231K101	12.7	4.4	27.5	6.7	31.0	25.0	1.0
B72225S4251K101	12.7	4.6	27.5	6.9	31.0	25.0	1.0
B72225S4271K101	12.7	4.7	27.5	7.2	31.0	25.0	1.0
B72225S4301K101	12.7	4.8	27.5	7.4	31.0	25.0	1.0
B72225S4321K101	12.7	4.9	27.5	7.6	31.0	25.0	1.0
B72225S4381K101	12.7	5.0	27.5	8.3	31.5	25.0	1.0
B72225S4421K101	12.7	5.2	27.5	8.6	31.5	25.0	1.0
B72225S4441K101	12.7	5.4	27.5	8.9	31.5	25.0	1.0
B72225S4461K101	12.7	5.6	27.5	9.1	31.5	25.0	1.0
B72225S4511K101	12.7	5.8	27.5	9.5	31.5	25.0	1.0
B72225S4551K101	12.7	6.0	27.5	10.0	32.0	25.0	1.0
B72225S4581K101	12.7	6.1	27.5	10.2	32.0	25.0	1.0
B72225S4621K101	12.7	6.2	27.5	10.6	32.0	25.0	1.0
B72225S4681K101	12.7	6.3	27.5	11.2	32.5	25.0	1.0
B72225S4751K101	12.7	6.5	27.5	11.7	32.5	25.0	1.0


Reliability data

Test	Test methods/conditions	Requirement
Varistor voltage	The voltage between two terminals with the specified measuring current applied is called V_V (1 mA _{DC} @ 0.2 ... 2 s).	To meet the specified value
Clamping voltage	The maximum voltage between two terminals with the specified standard impulse current (8/20 μ s) applied.	To meet the specified value
Endurance at upper category temperature	1000 h at UCT After having continuously applied the maximum allowable AC voltage at UCT ± 2 °C for 1000 h, the specimen shall be stored at room temperature and normal humidity for 1 to 2 h. Thereafter, the change of V_V shall be measured.	$ \Delta V/V$ (1 mA) $\leq 10\%$
Surge current derating, 8/20 μ s	10 surge currents (8/20 μ s), unipolar, interval 30 s, amplitude corresponding to derating curve for 10 impulses at 20 μ s	$ \Delta V/V$ (1 mA) $\leq 10\%$ (measured in direction of surge current) No visible damage
Surge current derating, 2 ms	10 surge currents (2 ms), unipolar, interval 120 s, amplitude corresponding to derating curve for 10 impulses at 2 ms	$ \Delta V/V$ (1 mA) $\leq 10\%$ (measured in direction of surge current) No visible damage
Electric strength	IEC 61051-1, test 4.9.2 Metal balls method, 2500 V _{RMS} , 60 s The varistor is placed in a container holding 1.6 \pm 0.2 mm diameter metal balls such that only the terminations of the varistor are protruding. The specified voltage shall be applied between both terminals of the specimen connected together and the electrode inserted between the metal balls.	No breakdown


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Test	Test methods/conditions	Requirement
Climatic sequence	<p>The specimen shall be subjected to:</p> <p>a) dry heat at UCT, 16 h, IEC 60068-2-2, test Ba</p> <p>b) damp heat, 1st cycle: 55 °C, 93% r. H., 24 h, IEC 60068-2-30, test Db</p> <p>c) cold, LCT, 2 h, IEC 60068-2-1, test Aa</p> <p>d) damp heat, additional 5 cycles: 55 °C/25 °C, 93% r. H., 24 h/cycle, IEC 60068-2-30, test Db.</p> <p>Then the specimen shall be stored at room temperature and normal humidity for 1 to 2 h.</p> <p>Thereafter, the change of V_V shall be measured. Thereafter, insulation resistance R_{ins} shall be measured at $V = 500 V$.</p>	$ \Delta V/V (1 mA) \leq 10\%$ $R_{ins} \geq 100 M\Omega$
Rapid change of temperature	IEC 60068-2-14, test Na, LCT/UCT, dwell time 30 min, 5 cycles	$ \Delta V/V (1 mA) \leq 5\%$ No visible damage
Damp heat, steady state	IEC 60068-2-78, test Ca The specimen shall be subjected to 40 ± 2 °C, 90 to 95% r. H. for 56 days without load / with 10% of the maximum continuous DC operating voltage V_{DC} . Then stored at room temperature and normal humidity for 1 to 2 h. Thereafter, the change of V_V shall be measured. Thereafter, insulation resistance R_{ins} shall be measured at $V = 500 V$ (insulated varistors only).	$ \Delta V/V (1 mA) \leq 10\%$ $R_{ins} \geq 100 M\Omega$


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Test	Test methods/conditions	Requirement
Solderability	<p>IEC 60068-2-20, test Ta, method 1 with modified conditions for lead-free solder alloys: 245 °C, 3 s:</p> <p>After dipping the terminals to a depth of approximately 3 mm from the body in a soldering bath of 245 °C for 3 s, the terminals shall be visually examined.</p>	<p>The inspection shall be carried out under adequate light with normal eyesight or with the assistance of a magnifier capable of giving a magnification of 4 to 10 times. The dipped surface shall be covered with a smooth and bright solder coating with no more than small amounts of scattered imperfections such as pinholes or un-wetted or de-wetted areas. These imperfections shall not be concentrated in one area.</p>
Resistance to soldering heat	<p>IEC 60068-2-20, test Tb, method 1A, 260 °C, 10 s:</p> <p>Each lead shall be dipped into a solder bath having a temperature of 260 ±5 °C to a point 2.0 to 2.5 mm from the body of the specimen, be held there for 10 ±1 s and then be stored at room temperature and normal humidity for 1 to 2 h.</p> <p>The change of V_V shall be measured and the specimen shall be visually examined.</p>	<p>$\Delta V/V (1 \text{ mA}) \leq 5\%$</p> <p>No visible damage</p>
Tensile strength	<p>IEC 60068-2-21, test Ua1</p> <p>After gradually applying the force specified below and keeping the unit fixed for 10 s, the terminal shall be visually examined for any damage.</p> <p>Force for wire diameter:</p> <p>0.6 mm = 10 N 0.8 mm = 10 N 1.0 mm = 20 N</p>	<p>$\Delta V/V (1 \text{ mA}) \leq 5\%$</p> <p>No break of solder joint, no wire break</p>



Test	Test methods/conditions	Requirement
Vibration	IEC 60068-2-6, test Fc, method B4 Frequency range: 10 ... 55 Hz Amplitude: 0.75 mm or 98 m/s ² Duration: 6 h (3 · 2 h) Pulse: sine wave After repeatedly applying a single harmonic vibration according to the table above. The change of V _v shall be measured and the specimen shall be visually examined.	ΔV/V (1 mA) ≤5% No visible damage
Bump	IEC 60068-2-29, test Eb Pulse duration: 6 ms Max. acceleration: 400 m/s ² Number of bumps: 4000 Pulse: half sine	ΔV/V (1 mA) ≤5% No visible damage
Fire hazard	IEC 60695-11-5 (needle flame test) Severity: vertical 10 s	5 s max.

Note:

UCT = Upper category temperature

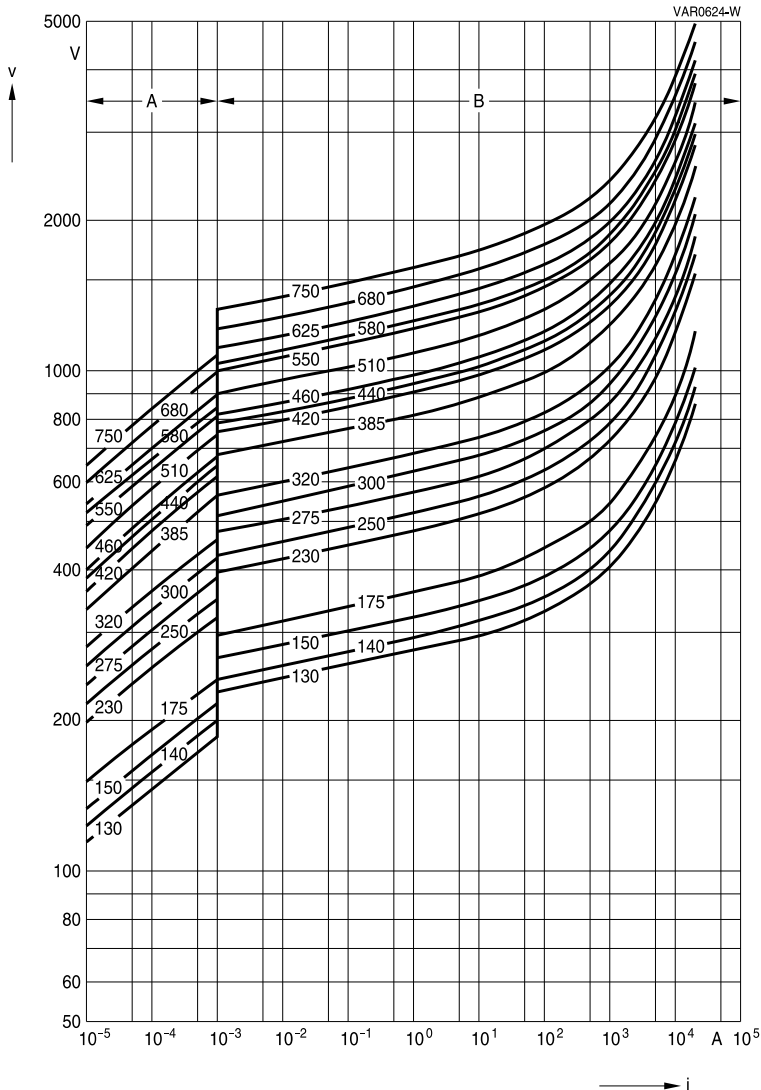
LCT = Lower category temperature

 R_{ins} = Insulation resistance



v/i characteristics

$v = f(i)$ - for explanation of the characteristics refer to "General technical information", 1.6.3
 A = Leakage current, B = Protection level } for worst-case varistor tolerances



SIOV-S25 ... E4R12



Derating curves

Maximum surge current $i_{max} = f(t_r, \text{pulse train})$

For explanation of the derating curves refer to "General technical information", section 1.8.1



SIOV-S25K130 ... K750E4R12



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Taping, packaging and lead configuration

1 EPCOS ordering code system

For leaded varistors





2 Taping and packaging of leaded varistors

Tape packaging for lead spacing \boxed{e} = 5 fully conforms to IEC 60286-2, while for lead spacings \boxed{e} = 7.5 and 10 the taping mode is based on this standard.

2.1 Taping in accordance with IEC 60286-2 for lead spacing 5.0 mm



2.2 Taping based on IEC 60286-2 for lead spacing 7.5 and 10 mm




2.3 Tape dimensions (in mm)

Symbol	$e = 5.0$	Tolerance	$e = 7.5$	Tolerance	$e = 10.0$	Tolerance	Remarks
w		max.		max.		max.	see tables in each series under "Dimensions"
th		max.		max.		max.	
d	0.6	± 0.05	0.8	± 0.05	1.0	± 0.05	
P ₀	12.7	± 0.3	12.7 ¹⁾	± 0.3	12.7	± 0.3	± 1 mm/20 sprocket holes
P ₁	3.85	± 0.7	8.95	± 0.8	7.7	± 0.8	
F	5.0	$+0.6/-0.1$	7.5	± 0.8	10.0	± 0.8	measured at top of component body
Δh	0	± 2.0	depends on s		depends on s		
Δp	0	± 1.3	0	± 2.0	0	± 2.0	
W	18.0	± 0.5	18.0	± 0.5	18.0	± 0.5	Peel-off force ≥ 5 N
W ₀	5.5	min.	11.0	min.	11.0	min.	
W ₁	9.0	± 0.5	9.0	$+0.75/-0.5$	9.0	$+0.75/-0.5$	
W ₂	3.0	max.	3.0	max.	3.0	max.	
H	18.0	$+2.0/-0$	18.0	$+2.0/-0$	18.0	$+2.0/-0$	2) 3)
H ₀	16.0 (18.0)	± 0.5	16.0 (18.0)	± 0.5	16.0	± 0.5	
H ₁	32.2	max.	45.0	max.	45.0	max.	
D ₀	4.0	± 0.2	4.0	± 0.2	4.0	± 0.2	without lead
t	0.9	max.	0.9	max.	0.9	max.	
L	11.0	max.	11.0	max.	11.0	max.	
L ₁	0.5	max.					

1) Taping with P₀ = 15.0 mm upon request

2) Applies only to uncrimped types

3) Applies only to crimped types (H₀ = 18 upon request)



2.4 Taping mode

Example: B72210S0271K1 5 1
|
Digit 14

Digit 14	Taping mode	Reel type	Seating plane height H_0 for crimped types mm	Seating plane height H for uncrimped types mm	Pitch distance P_0 mm
0	—	Bulk	—	—	—
1	G	I	16	18	12.7
2	G2	I	18	—	12.7
3	G3	II	16	18	12.7
4	G4	II	18	—	12.7
5	G5	III	16	18	12.7
6	GA	Ammo pack	16	18	12.7
7	G2A	Ammo pack	18	—	12.7

Internal coding for special taping

G6	III	18	—	12.7
G10	II	16	18	15.0
G11	II	18	—	15.0
G10A	Ammo pack	16	18	15.0
G11A	Ammo pack	18	—	15.0

2.5 Reel dimension



Dimensions (in mm)

Reel type	d	f	n	w
I	360 max.	31 ±1	approx. 45	54 max.
II	360 max.	31 ±1	approx. 55	64 max.
III	500 max.	23 ±1	approx. 59	72 max.

If reel type III is not compatible with insertion equipment because of its large diameter, nominal disk diameter 10 mm and 14 mm can be supplied on reel II upon request (taping mode G3).



2.6 Ammo pack dimensions



VAR0402-G

3 Lead configuration

Straight leads are standard for disk varistors. Other lead configurations as crimp style or customer-specific lead wire length according to 3.1, 3.2, 3.3 and 3.4 are optional. Crimped leads (non-standard) are differently crimped for technical reasons; the individual crimp styles are denoted by consecutive numbers (S, S2 through S5) as shown in the dimensional drawings below.

The crimp styles of the individual types can be seen from the type designation in the ordering tables.

3.1 Crimp style mode

Example: B72210S0271K **5** 01

Digit 13

Digit 13 of ordering code	Crimp style	Figure
1	Standard, straight leads	1
2	S2	2
3	S3	3
5	S5	4
Available upon request		
Internal coding	—	5



3.2 Standard leads and non-standard crimp styles

The basic dimensions in figure 1 to 5 are valid for types with either round or square (EnergetiQ series) component head.

Standard, straight leads



Figure 1

Non-standard, crimp style S2



Figure 2

Non-standard, crimp style S3



Figure 3

Non-standard, crimp style S5



Figure 4



3.3 Trimmed leads (non-standard)

Varistors with cut leads available upon request.

Lead length tolerances:

Straight leads ± 0.8 mm

Crimped leads ± 0.5 mm

Minimum lead length 3.0 mm



1) Seating plane to IEC 60717

*) For round component head

***) For EnergetiQ series, square component head

VAR0642-U-E

Figure 5



Cautions and warnings

General

1. EPCOS metal oxide varistors are designed for specific applications and should not be used for purposes not identified in our specifications, application notes and data books unless otherwise agreed with EPCOS during the design-in-phase.
2. Ensure suitability of SIOVs through reliability testing during the design-in phase. SIOVs should be evaluated taking into consideration worst-case conditions.
3. For applications of SIOVs in line-to-ground circuits based on various international and local standards there are restrictions existing or additional safety measures required.

Storage

1. Store SIOVs only in original packaging. Do not open the package prior to processing.
2. Recommended storage conditions in original packaging:
 Storage temperature: $-25\text{ °C} \dots +45\text{ °C}$,
 Relative humidity: $<75\%$ annual average,
 $<95\%$ on maximum 30 days a year.
 Dew precipitation: is to be avoided.
3. Avoid contamination of an SIOV's during storage, handling and processing.
4. Avoid storage of SIOVs in harmful environments that can affect the function during long-term operation (examples given under operation precautions).
5. The SIOV type series should be soldered after shipment from EPCOS within the time specified:

SIOV-S, -Q, -LS, -B, -SNF	24 months
ETFV/ T series, -CU	12 months.

Handling

1. SIOVs must not be dropped.
2. Components must not be touched with bare hands. Gloves are recommended.
3. Avoid contamination of the surface of SIOV electrodes during handling, be careful of the sharp edge of SIOV electrodes.

Soldering (where applicable)

1. Use rosin-type flux or non-activated flux.
2. Insufficient preheating may cause ceramic cracks.
3. Rapid cooling by dipping in solvent is not recommended.
4. Complete removal of flux is recommended.
5. Temperatures of all preheat stages and the solder bath must be strictly controlled especially for T series (T14 and T20).



Mounting

1. Potting, sealing or adhesive compounds can produce chemical reactions in the SIOV ceramic that will degrade the component's electrical characteristics.
2. Overloading SIOVs may result in ruptured packages and expulsion of hot materials. For this reason SIOVs should be physically shielded from adjacent components.

Operation

1. Use SIOVs only within the specified temperature operating range.
2. Use SIOVs only within the specified voltage and current ranges.
3. Environmental conditions must not harm SIOVs. Use SIOVs only in normal atmospheric conditions. Avoid use in deoxidizing gases (chlorine gas, hydrogen sulfide gas, ammonia gas, sulfuric acid gas etc), corrosive agents, humid or salty conditions. Contact with any liquids and solvents should be prevented.

Display of ordering codes for EPCOS products

The ordering code for one and the same EPCOS product can be represented differently in data sheets, data books, other publications, on the EPCOS website, or in order-related documents such as shipping notes, order confirmations and product labels. **The varying representations of the ordering codes are due to different processes employed and do not affect the specifications of the respective products.** Detailed information can be found on the Internet under www.epcos.com/orderingcodes


Symbols and terms

Symbol	Term
C	Capacitance
C_{typ}	Typical capacitance
i	Current
i_c	Current at which $V_{c, max}$ is measured
I_{leak}	Leakage current
i_{max}	Maximum surge current (also termed peak current)
I_{max}	Maximum discharge current
I_n	Nominal discharge current to UL 1449
LCT	Lower category temperature
L_{typ}	Typical inductance
P_{max}	Maximum average power dissipation
R_{ins}	Insulation resistance
R_{min}	Minimum resistance
T_A	Ambient temperature
t_r	Duration of equivalent rectangular wave
UCT	Upper category temperature
v	Voltage
V_{clamp}	Clamping voltage
$V_{c, max}$	Maximum clamping voltage at specified current i_c
V_{DC}	DC operating voltage
V_{jump}	Maximum jump start voltage
V_{max}	Maximum voltage
V_{op}	Operating voltage
V_{RMS}	AC operating voltage, root-mean-square value
$V_{RMS, op, max}$	Root-mean-square value of max. DC operating voltage incl. ripple current
V_{surge}	Super imposed surge voltage
V_V	Varistor voltage
ΔV_V	Tolerance of varistor voltage
W_{LD}	Maximum load dump
W_{max}	Maximum energy absorption
e	Lead spacing

All dimensions are given in mm.

The commas used in numerical values denote decimal points.

Important notes

The following applies to all products named in this publication:

1. Some parts of this publication contain **statements about the suitability of our products for certain areas of application**. These statements are based on our knowledge of typical requirements that are often placed on our products in the areas of application concerned. We nevertheless expressly point out **that such statements cannot be regarded as binding statements about the suitability of our products for a particular customer application**. As a rule we are either unfamiliar with individual customer applications or less familiar with them than the customers themselves. For these reasons, it is always ultimately incumbent on the customer to check and decide whether a product with the properties described in the product specification is suitable for use in a particular customer application.
2. We also point out that **in individual cases, a malfunction of electronic components or failure before the end of their usual service life cannot be completely ruled out in the current state of the art, even if they are operated as specified**. In customer applications requiring a very high level of operational safety and especially in customer applications in which the malfunction or failure of an electronic component could endanger human life or health (e.g. in accident prevention or life-saving systems), it must therefore be ensured by means of suitable design of the customer application or other action taken by the customer (e.g. installation of protective circuitry or redundancy) that no injury or damage is sustained by third parties in the event of malfunction or failure of an electronic component.
3. **The warnings, cautions and product-specific notes must be observed.**
4. In order to satisfy certain technical requirements, **some of the products described in this publication may contain substances subject to restrictions in certain jurisdictions (e.g. because they are classed as hazardous)**. Useful information on this will be found in our Material Data Sheets on the Internet (www.tdk-electronics.tdk.com/material). Should you have any more detailed questions, please contact our sales offices.
5. We constantly strive to improve our products. Consequently, **the products described in this publication may change from time to time**. The same is true of the corresponding product specifications. Please check therefore to what extent product descriptions and specifications contained in this publication are still applicable before or when you place an order.

We also **reserve the right to discontinue production and delivery of products**. Consequently, we cannot guarantee that all products named in this publication will always be available. The aforementioned does not apply in the case of individual agreements deviating from the foregoing for customer-specific products.
6. Unless otherwise agreed in individual contracts, **all orders are subject to our General Terms and Conditions of Supply**.
7. **Our manufacturing sites serving the automotive business apply the IATF 16949 standard**. The IATF certifications confirm our compliance with requirements regarding the quality management system in the automotive industry. Referring to customer requirements and customer specific requirements ("CSR") TDK always has and will continue to have the policy of respecting individual agreements. Even if IATF 16949 may appear to support the acceptance of unilateral requirements, we hereby like to emphasize that **only requirements mutually agreed upon can and will be implemented in our Quality Management System**. For clarification purposes we like to point out that obligations from IATF 16949 shall only become legally binding if individually agreed upon.

Important notes

8. The trade names EPCOS, CeraCharge, CeraDiode, CeraLink, CeraPad, CeraPlas, CSMP, CTVS, DeltaCap, DigiSiMic, ExoCore, FilterCap, FormFit, LeaXield, MiniBlue, MiniCell, MKD, MKK, MotorCap, PCC, PhaseCap, PhaseCube, PhaseMod, PhiCap, PowerHap, PQSine, PQvar, SIFERRIT, SIFI, SIKOREL, SilverCap, SIMDAD, SiMic, SIMID, SineFormer, SIOV, ThermoFuse, WindCap are **trademarks registered or pending** in Europe and in other countries. Further information will be found on the Internet at www.tdk-electronics.tdk.com/trademarks.

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Данный компонент на территории Российской Федерации

Вы можете приобрести в компании MosChip.

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Вы можете разместить у нас заказ для любого Вашего проекта, будь то серийное производство или разработка единичного прибора.

В нашем ассортименте представлены ведущие мировые производители активных и пассивных электронных компонентов.

Нашей специализацией является поставка электронной компонентной базы двойного назначения, продукции таких производителей как XILINX, Intel (ex.ALTERA), Vicor, Microchip, Texas Instruments, Analog Devices, Mini-Circuits, Amphenol, Glenair.

Сотрудничество с глобальными дистрибьюторами электронных компонентов, предоставляет возможность заказывать и получать с международных складов практически любой перечень компонентов в оптимальные для Вас сроки.

На всех этапах разработки и производства наши партнеры могут получить квалифицированную поддержку опытных инженеров.

Система менеджмента качества компании отвечает требованиям в соответствии с ГОСТ Р ИСО 9001, ГОСТ РВ 0015-002 и ЭС РД 009

Офис по работе с юридическими лицами:

105318, г.Москва, ул.Щербаковская д.3, офис 1107, 1118, ДЦ «Щербаковский»

Телефон: +7 495 668-12-70 (многоканальный)

Факс: +7 495 668-12-70 (доб.304)

E-mail: info@moschip.ru

Skype отдела продаж:

moschip.ru

moschip.ru_4

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